


<b>Search Notes</b> 	<b>Application/Control No.</b> 10586706	<b>Applicant(s)/Patent Under Reexamination</b> KOIKE ET AL.
	<b>Examiner</b> DUC M NGUYEN	<b>Art Unit</b> 2618

SEARCHED			
Class	Subclass	Date	Examiner
455	574, 343.2, 343.3, 133, 134, 221, 226.2	10/22/08	DN
381	11, 12	10/22/08	DN

SEARCH NOTES		
Search Notes	Date	Examiner
see EAST search history	10/22/08	DN
	10/23/08	DN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/DUC M NGUYEN/ Primary Examiner.Art Unit 2618
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